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19-1745; Rev 3; 8/10

EVALUATION KIT AVAILABLE

## **10-Bit, 40Msps, 3.0V, Low-Power ADC with Internal Reference**

## **General Description**

The MAX1444 10-bit, 3V analog-to-digital converter (ADC) features a pipelined 10-stage ADC architecture with fully differential wideband track-and-hold (T/H) input and digital error correction incorporating a fully differential signal path. This ADC is optimized for low-power, high dynamic performance applications in imaging and digital communications. The MAX1444 operates from a single 2.7V to 3.6V supply, consuming only 57mW while delivering a 59.5dB signal-to-noise ratio (SNR) at a 20MHz input frequency. The fully differential input stage has a 400MHz -3dB bandwidth and may be operated with single-ended inputs. In addition to low operating power, the MAX1444 features a 5µA power-down mode for idle periods.

An internal 2.048V precision bandgap reference is used to set the ADC full-scale range. A flexible reference structure allows the user to supply a buffered, direct, or externally derived reference for applications requiring increased accuracy or a different input voltage range.

Higher speed, pin-compatible versions of the MAX1444 are also available. Please refer to the MAX1446 data sheet (60Msps) and the MAX1448 data sheet (80Msps).

The MAX1444 has parallel, offset binary, CMOS-compatible three-state outputs that can be operated from 1.7V to 3.6V to allow flexible interfacing. The device is available in a 5x5mm 32-pin TQFP package and is specified over the extended industrial (-40°C to +85°C) temperature range.

**Applications** 

Ultrasound Imaging CCD Imaging Baseband and IF Digitization Digital Set-Top Boxes Video Digitizing Applications

## \_\_ Features

- Single 3.0V Operation
- Excellent Dynamic Performance 59.5dB SNR at f<sub>IN</sub> = 20MHz 74dBc SFDR at f<sub>IN</sub> = 20MHz
- Low Power
  19mA (Normal Operation)
  5µA (Shutdown Mode)
- Fully Differential Analog Input
- Wide 2Vp-p Differential Input Voltage Range
- ♦ 400MHz -3dB Input Bandwidth
- On-Chip 2.048V Precision Bandgap Reference
- ♦ CMOS-Compatible Three-State Outputs
- ♦ 32-Pin TQFP Package
- Evaluation Kit Available

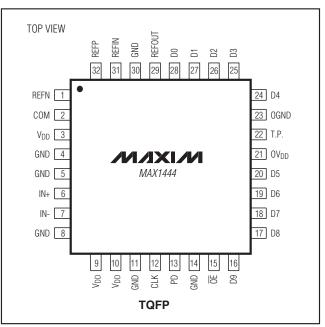
## **Ordering Information**

PART	TEMP RANGE	PIN-PACKAGE
MAX1444EHJ	-40°C to +85°C	32 TQFP
MAX1444EHJ/V+	-40°C to +85°C	32 TQFP

N Denotes an automotive qualified part.

+Denotes a lead(Pb)-free/RoHS-compliant package.

## **Pin Configuration**



Functional Diagram appears at end of data sheet.

## 

\_\_\_ Maxim Integrated Products 1

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

# MAX1444

## **ABSOLUTE MAXIMUM RATINGS**

V <sub>DD</sub> , OV <sub>DD</sub> to GND	0.3V to +3.6V
OGND to GND	0.3V to +0.3V
IN+, IN- to GND	0.3V to V <sub>DD</sub>
REFIN, REFOUT, REFP,	
REFN, and COM to GND	0.3V to (V <sub>DD</sub> + 0.3V)
OE, PD, CLK to GND	0.3V to $(V_{DD} + 0.3V)$
D9–D0 to GND	0.3V to $(OV_{DD} + 0.3V)$

Continuous Power Dissipation ( $T_A = +70^{\circ}$ C) 32-Pin TQFP (derate 18.7mW/°C above +70°C).....1495.3mW Operating Temperature Range .....-40°C to +85°C Storage Temperature Range ....-60°C to +150°C Lead Temperature (soldering, 10s) .....+300°C Soldering Temperature (reflow) .....+260°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## **ELECTRICAL CHARACTERISTICS**

 $(V_{DD} = 3V; OV_{DD} = 2.7V; 0.1\mu$ F and 1µF capacitors from REFP, REFN, and COM to GND;  $V_{REFIN} = 2.048V$ ; REFOUT connected to REFIN through a 10k $\Omega$  resistor;  $V_{IN} = 2V_{P-P}$  (differential with respect to COM);  $C_L = 10$ pF at digital outputs;  $f_{CLK} = 40$ MHz;  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.  $\ge +25^{\circ}$ C guaranteed by production test,  $< +25^{\circ}$ C guaranteed by design and characterization; typical values are at  $T_A = +25^{\circ}$ C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	МАХ	UNITS
DC ACCURACY	•	•	•			•
Resolution			10			Bits
Integral Nonlinearity	INL	f <sub>IN</sub> = 7.51MHz, T <sub>A</sub> ≥ +25°C		±0.6	±1.9	LSB
Differential Nonlinearity	DNL	f <sub>IN</sub> = 7.51MHz, no missing codes guaranteed		±0.4	±1.0	LSB
Offset Error				<±0.1	±1.7	% FS
Gain Error		T <sub>A</sub> ≥ +25°C		0	±2	% FS
ANALOG INPUT						
Input Differential Range	VDIFF	Differential or single-ended inputs		±1.0		V
Common-Mode Voltage Range	VCOM			V <sub>DD</sub> /2 ±0.5		V
Input Resistance	R <sub>IN</sub>	Switched capacitor load		50		kΩ
Input Capacitance	CIN			5		рF
CONVERSION RATE	·	·	·			
Maximum Clock Frequency	fCLK		40			MHz
Data Latency				5.5		Cycles
DYNAMIC CHARACTERISTICS	(f <sub>CLK</sub> = 40MF	Hz, 4096-point FFT)				
		$f_{IN} = 7.51 MHz$	57.5	59.5		
Signal-to-Noise Ratio	SNR	$f_{IN} = 19.91 MHz$	56.3	59.5		dB
		f <sub>IN</sub> = 39.9MHz (Note 1)		58.5		
		$f_{IN} = 7.51 MHz$	57	59.4		
Signal-to-Noise + Distortion (Up to 5th harmonic)	SINAD	$f_{IN} = 19.91 MHz$	56.1	59		dB
		f <sub>IN</sub> = 39.9MHz (Note 1)		58.3		
		$f_{IN} = 7.51 MHz$	67	75		
Spurious-Free Dynamic Range	SFDR	$f_{IN} = 19.91 MHz$	66	66 74		
		f <sub>IN</sub> = 39.9 MHz (Note 1)		72.5		

## **ELECTRICAL CHARACTERISTICS (continued)**

 $(V_{DD} = 3V; OV_{DD} = 2.7V; 0.1\mu$ F and 1 $\mu$ F capacitors from REFP, REFN, and COM to GND;  $V_{REFIN} = 2.048V$ ; REFOUT connected to REFIN through a 10k $\Omega$  resistor;  $V_{IN} = 2V_{P-P}$  (differential with respect to COM);  $C_L = 10$ pF at digital outputs;  $f_{CLK} = 40$ MHz;  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.  $\geq +25^{\circ}$ C guaranteed by production test,  $< +25^{\circ}$ C guaranteed by design and characterization; typical values are at  $T_A = +25^{\circ}$ C.)

PARAMETER	SYMBOL	CONDITIONS	MIN TYP	МАХ	UNITS
		f <sub>IN</sub> = 7.51MHz	-75		
Third-Harmonic Distortion	HD3	f <sub>IN</sub> = 19.91MHz	-74		dBc
		f <sub>IN</sub> = 39.9MHz (Note 1)	-72.5		
Two-Tone Intermodulation Distortion	IMD	$f_1 = 11.5MHz$ at -6.5dBFS $f_2 = 13.5MHz$ at -6.5dBFS (Note 2)	-76		dBc
Third-Order Intermodulation Distortion	IM3	f <sub>1</sub> = 11.5MHz at -6.5dBFS f <sub>2</sub> = 13.5MHz at -6.5dBFS (Note 2)	-76		dBc
		f <sub>IN</sub> = 7.51MHz	-73.8	-65	
Total Harmonic Distortion (First 4 Harmonics)	THD	f <sub>IN</sub> = 19.91MHz	-72.2	-65	dBc
(FIISE 4 Harmonics)		f <sub>IN</sub> = 39.9MHz (Note 1)	-70		
Small-Signal Bandwidth		Input at -20dBFS, differential inputs	500		MHz
Full-Power Bandwidth	FPBW	Input at -0.5dBFS, differential inputs	400		MHz
Aperture Delay	t <sub>AD</sub>		1		ns
Aperture Jitter	t <sub>AJ</sub>		2		psrms
Overdrive Recovery Time		For 1.5 × full-scale input	2		ns
Differential Gain			±1		%
Differential Phase			±0.25		Degrees
Output Noise		IN+ = IN- = COM	0.2		LSB <sub>RMS</sub>
INTERNAL REFERENCE			-		•
Reference Output Voltage	REFOUT		2.048 ±1%	0	V
Reference Temperature Coefficient	TCREF		60		ppm/°C
Load Regulation			1.25		mV/mA
<b>BUFFERED EXTERNAL REFER</b>	RENCE (VREFIN	<sub>N</sub> = 2.048V)			
REFIN Input Voltage	VREFIN		2.048		V
Positive Reference Output Voltage	VREFP		2.012		V
Negative Reference Output Voltage	V <sub>REFN</sub>		0.988		V
Common-Mode Level	VCOM		V <sub>DD</sub> / 2		V
Differential Reference Output Voltage Range	$\Delta V_{REF}$	$\Delta V_{REF} = V_{REFP} - V_{REFN}, T_A \ge +25^{\circ}C$	0.98 1.024	1.07	V
REFIN Resistance	RREFIN		>50		MΩ

## **ELECTRICAL CHARACTERISTICS (continued)**

 $(V_{DD} = 3V; OV_{DD} = 2.7V; 0.1\mu$ F and 1µF capacitors from REFP, REFN, and COM to GND;  $V_{REFIN} = 2.048V$ ; REFOUT connected to REFIN through a 10k $\Omega$  resistor;  $V_{IN} = 2V_{P-P}$  (differential with respect to COM);  $C_L = 10$ pF at digital outputs;  $f_{CLK} = 40$ MHz;  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.  $\ge +25^{\circ}$ C guaranteed by production test,  $< +25^{\circ}$ C guaranteed by design and characterization; typical values are at  $T_A = +25^{\circ}$ C.)

PARAMETER	SYMBOL	CONDITIONS	MIN TYP MA	X UNITS
Maximum REFP, COM Source Current	ISOURCE		5	mA
Maximum REFP, COM Sink Current	ISINK		-250	μΑ
Maximum REFN Source Current	ISOURCE		250	μΑ
Maximum REFN Sink Current	ISINK		-5	mA
UNBUFFERED EXTERNAL REF	ERENCE (VF	REFIN = AGND, reference voltage applied	to REFP, REFN, and COM)	
REFP, REFN Input Resistance	R <sub>REFP</sub> , R <sub>REFN</sub>	Measured between REFP and COM and REFN and COM	4	kΩ
REFP, REFN, COM Input Capacitance	CIN		15	pF
Differential Reference Input Voltage Range	$\Delta V_{REF}$	$\Delta V_{REF} = V_{REFP} - V_{REFN}$	1.024 ±10%	V
COM Input Voltage Range	V <sub>COM</sub>		V <sub>DD</sub> / 2 ±10%	V
REFP Input Voltage	VREFP		V <sub>COM</sub> + ΔV <sub>REF</sub> / 2	V
REFN Input Voltage	VREFN		Vcom - ΔV <sub>REF</sub> / 2	V
DIGITAL INPUTS (CLK, PD, OE)	•			•
Input High Threshold	Ver	CLK	0.8 × V <sub>DD</sub>	V
Input High Threshold VIH		PD, OE	0.8 × OV <sub>DD</sub>	V
Input Low Threshold		CLK	0.2 VD	
input Low Threshold	VIL	PD, OE	0.2 OV[	×

## **ELECTRICAL CHARACTERISTICS (continued)**

 $(V_{DD} = 3V; OV_{DD} = 2.7V; 0.1\mu$ F and 1 $\mu$ F capacitors from REFP, REFN, and COM to GND;  $V_{REFIN} = 2.048V$ ; REFOUT connected to REFIN through a 10k $\Omega$  resistor;  $V_{IN} = 2V_{P-P}$  (differential with respect to COM);  $C_L = 10$ pF at digital outputs;  $f_{CLK} = 40$ MHz;  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.  $\geq +25^{\circ}$ C guaranteed by production test,  $< +25^{\circ}$ C guaranteed by design and characterization; typical values are at  $T_A = +25^{\circ}$ C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
Input Hysteresis	V <sub>HYST</sub>			0.1		V
	Ιн	$V_{IH} = V_{DD} = OV_{DD}$			±5	
Input Leakage	١ <sub>١L</sub>	$V_{IL} = OV$			±5	μA
Input Capacitance	CIN			5		pF
DIGITAL OUTPUTS (D9–D0)						
Output Voltage Low	V <sub>OL</sub>	$I_{SINK} = 200 \mu A$			0.2	V
Output Voltage High	VOH	ISOURCE = 200µA	OV <sub>DD</sub> - 0.2			V
Three-State Leakage Current	ILEAK	$\overline{OE} = OV_{DD}$			±10	μA
Three-State Output Capacitance	Соит	$\overline{OE} = OV_{DD}$		5		рF
POWER REQUIREMENTS						
Analog Supply Voltage	V <sub>DD</sub>		2.7	3.0	3.6	V
Output Supply Voltage	OV <sub>DD</sub>		1.7	3.0	3.6	V
Angles Current Current	h	Operating, f <sub>IN</sub> = 19.91MHz at -0.5dBFS		19	27	mA
Analog Supply Current	IVDD	Shutdown, clock idle, $PD = \overline{OE} = OV_{DD}$		4	15	μΑ
Output Supply Current		Operating, f <sub>IN</sub> = 19.91MHz at -0.5dBFS		4.5		mA
Output Supply Current	Iovdd	Shutdown, clock idle, $PD = \overline{OE} = OV_{DD}$		1	20	μΑ
Power-Supply Rejection	PSRR	Offset		±0.1		mV/V
Fower-supply nejection	ronn	Gain		±0.1		%/V
TIMING CHARACTERISTICS						
CLK Rise to Output Data Valid	t <sub>DO</sub>	Figure 6 (Note 3)		5	8	ns
OE Fall to Output Enable	<b>t</b> ENABLE	Figure 5		10		ns
OE Rise to Output Disable	<b>t</b> DISABLE	Figure 5		15		ns
CLK Pulse Width High	tсн	Figure 6, clock period 25ns		12.5 ±3.8		ns
CLK Pulse Width Low	tCL	Figure 6, clock period 25ns		12.5 ±3.8		ns
Wake-up Time	twake	(Note 4)		1.7		μs

Note 1: SNR, SINAD, THD, SFDR, and HD3 are based on an analog input voltage of -0.5dBFS referenced to a 1.024V full-scale input voltage range.

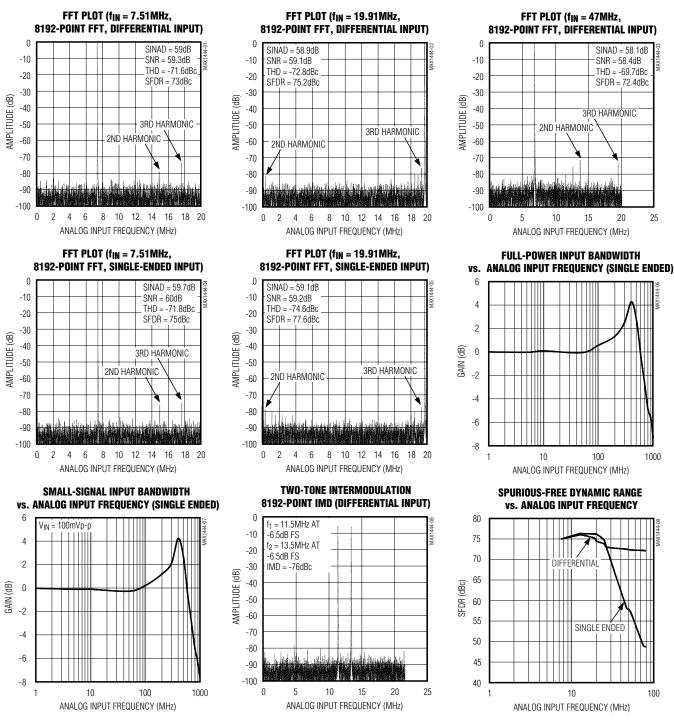
**Note 2:** Intermodulation distortion is the total power of the intermodulation products relative to the individual carrier. This number is 6dB better if referenced to the two-tone envelope.

Note 3: Digital outputs settle to V\_IH, V\_IL.

Note 4: REFIN is driven externally. REFP, COM, and REFN are left open while powered down.

 $(V_{DD} = 3.0V, OV_{DD} = 2.7V, internal reference, differential input at -0.5dB FS, f_{CLK} = 40MHz, C_L \approx 10pF, T_A = +25^{\circ}C, unless otherwise noted.)$ 

**Typical Operating Characteristics** 

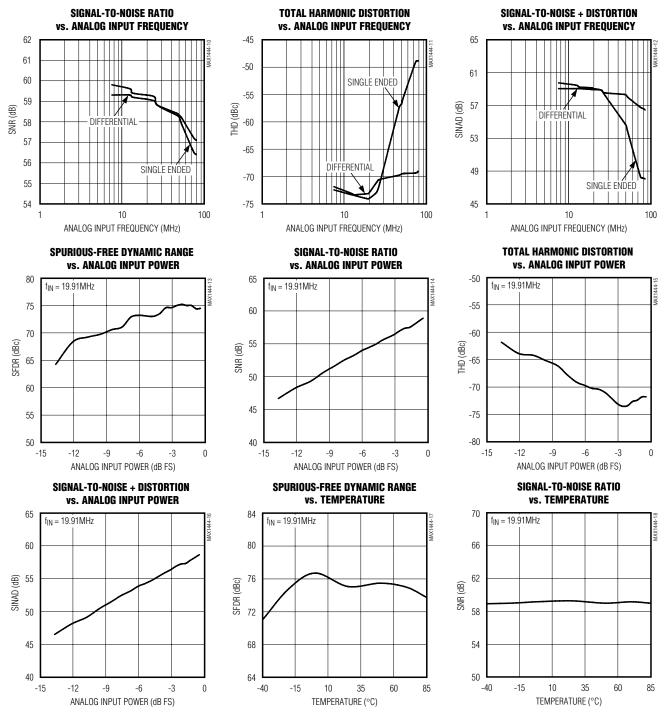


**MAX1444** 

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## \_Typical Operating Characteristics (continued)

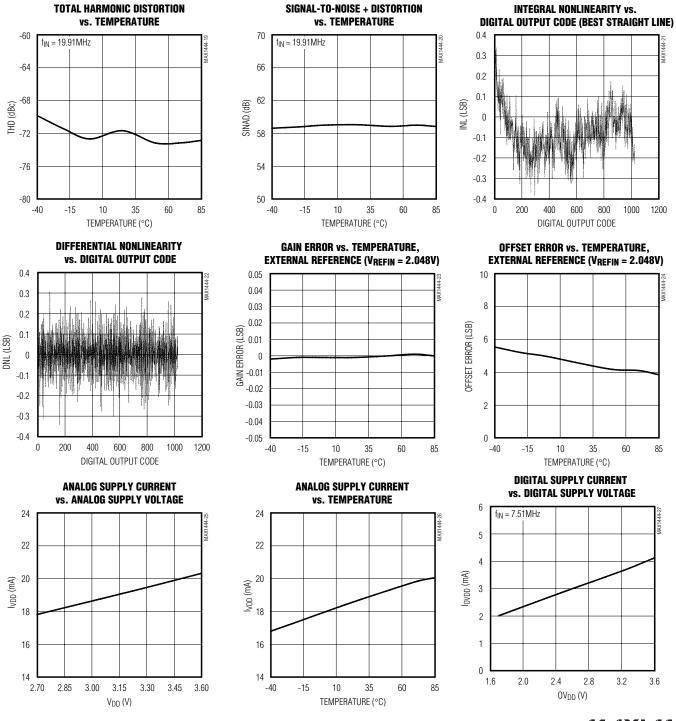
 $(V_{DD} = 3.0V, OV_{DD} = 2.7V, internal reference, differential input at -0.5dB FS, f_{CLK} = 40MHz, C_L \approx 10pF, T_A = +25^{\circ}C, unless otherwise noted.)$ 



**MAX1444** 

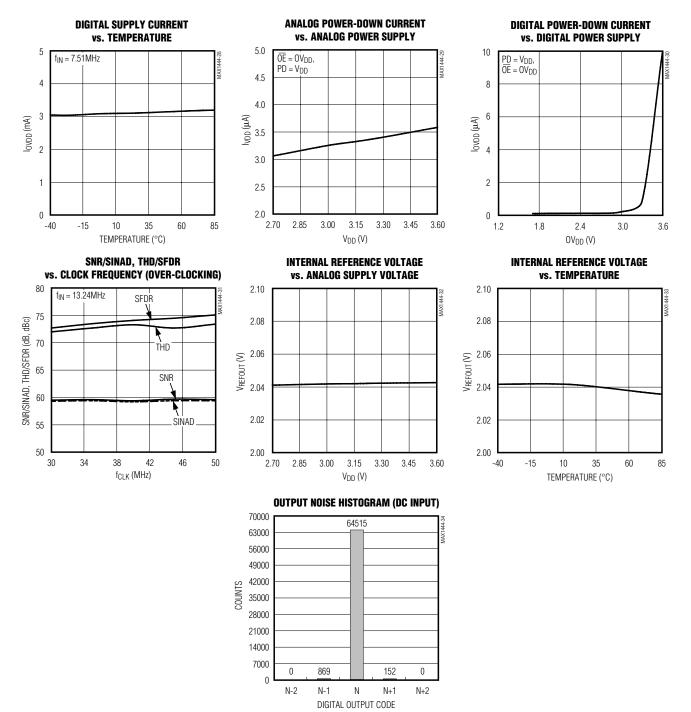
## \_Typical Operating Characteristics (continued)

(V<sub>DD</sub> = 3.0V, OV<sub>DD</sub> = 2.7V, internal reference, differential input at -0.5dB FS,  $f_{CLK}$  = 40MHz,  $C_L \approx 10$ pF,  $T_A$  = +25°C, unless otherwise noted.)



## Typical Operating Characteristics (continued)

 $(V_{DD} = 3.0V, OV_{DD} = 2.7V, internal reference, differential input at -0.5dB FS, f_{CLK} = 40MHz, C_L \approx 10pF, T_A = +25^{\circ}C, unless otherwise noted.)$ 



## **Pin Description**

PIN	NAME	FUNCTION
1	REFN	Lower Reference. Conversion range is $\pm$ (V <sub>REFP</sub> - V <sub>REFN</sub> ). Bypass to GND with a > 0.1µF capacitor.
2	COM	Common-Mode Voltage Output. Bypass to GND with a >0.1 $\mu$ F capacitor.
3, 9, 10	V <sub>DD</sub>	Analog Supply Voltage. Bypass to GND with a capacitor combination of 2.2 $\mu$ F in parallel with 0.1 $\mu$ F.
4, 5, 8, 11, 14, 30	GND	Analog Ground
6	IN+	Positive Analog Input. For single-ended operation, connect signal source to IN+.
7	IN-	Negative Analog Input. For single-ended operation, connect IN- to COM.
12	CLK	Conversion Clock Input
13	PD	Power Down Input. High: Power-down mode. Low: Normal operation.
15	ŌĒ	Output Enable Input. High: Digital outputs disabled. Low: Digital outputs enabled.
16–20	D9-D5	Three-State Digital Outputs D9–D5. D9 is the MSB.
21	OV <sub>DD</sub>	Output Driver Supply Voltage. Bypass to GND with a capacitor combination of 2.2 $\mu$ F in parallel with 0.1 $\mu$ F.
22	T.P.	Test Point. Do not connect.
23	OGND	Output Driver Ground
24–28	D4-D0	Three-State Digital Outputs D4–D0. D0 is the LSB.
29	REFOUT	Internal Reference Voltage Output. May be connected to REFIN through a resistor or a resistor-divider.
31	REFIN	Reference Input. $V_{REFIN} = 2 \times (V_{REFP} - V_{REFN})$ . Bypass to GND with a >0.1µF capacitor.
32	REFP	Upper Reference. Conversion range is $\pm (V_{REFP}$ - $V_{REFN}).$ Bypass to GND with a >0.1 $\mu F$ capacitor.

## **Detailed Description**

The MAX1444 uses a 10-stage, fully differential, pipelined architecture (Figure 1) that allows for high-speed conversion while minimizing power consumption. Each sample moves through a pipeline stage every half-clock cycle. Counting the delay through the output latch, the clock-cycle latency is 5.5.

A 1.5-bit (2-comparator) flash ADC converts the held input voltage into a digital code. The following digitalto-analog converter (DAC) converts the digitized result back into an analog voltage, which is then subtracted from the original held input signal. The resulting error signal is then multiplied by two, and the product is passed along to the next pipeline stage where the process is repeated until the signal has been processed by all 10 stages. Each stage provides a 1-bit resolution.

#### Input Track-and-Hold Circuit

Figure 2 displays a simplified functional diagram of the input track-and-hold (T/H) circuit in both track and hold mode. In track mode, switches S1, S2a, S2b, S4a, S4b, S5a, and S5b are closed. The fully differential circuit samples the input signal onto the two capacitors (C2a and C2b). Switches S2a and S2b set the common mode for the amplifier input. The resulting differential

MDAC VIN VOUT T/H FLASH DAC ADC 1.5 BITS VIN STAGE 1 STAGE 2 STAGE 10 DIGITAL ALIGNMENT LOGIC 10 D9-D0 VIN = INPUT VOLTAGE BETWEEN IN+ AND IN- (DIFFERENTIAL OR SINGLE-ENDED)

Figure 1. Pipelined Architecture—Stage Blocks

voltage is held on C2a and C2b. Switches S4a, S4b, S5a, S5b, S1, S2a, and S2b are then opened before S3a, S3b, and S4c are closed, connecting capacitors C1a and C1b to the amplifier output. This charges C1a and C1b to the same values originally held on C2a and C2b. This value is then presented to the first-stage quantizer and isolates the pipeline from the fast-chang-ing input. The wide-input-bandwidth T/H amplifier allows the MAX1444 to track and sample/hold analog inputs of high frequencies beyond Nyquist. The analog inputs (IN+ and IN-) can be driven either differentially or single-ended. It is recommended to match the impedance of IN+ and IN- and set the common-mode voltage to midsupply (VDD/2) for optimum performance.

**Analog Input and Reference Configuration** The MAX1444 full-scale range is determined by the internally generated voltage difference between REFP  $(V_{DD}/2 + V_{REFIN}/4)$  and REFN  $(V_{DD}/2 - V_{REFIN}/4)$ . The ADC's full-scale range is user-adjustable through the REFIN pin, which provides a high input impedance for this purpose. REFOUT, REFP, COM  $(V_{DD}/2)$ , and REFN are internally buffered, low-impedance outputs.

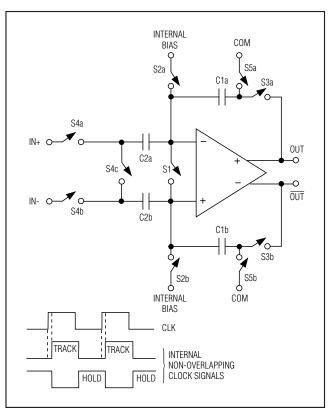


Figure 2. Internal T/H Circuit

MAX1444

The MAX1444 provides three modes of reference operation:

- Internal reference mode
- Buffered external reference mode
- Unbuffered external reference mode

In internal reference mode, the internal reference output (REFOUT) can be connected to the REFIN pin through a resistor (e.g.,  $10k\Omega$ ) or resistor-divider if an application requires a reduced full-scale range. For stability purposes, it is recommended to bypass REFIN with a >10nF capacitor to GND.

In buffered external reference mode, the reference voltage levels can be adjusted externally by applying a stable and accurate voltage at REFIN. In this mode, REFOUT may be left open or connected to REFIN through a >10k $\Omega$  resistor.

In unbuffered external reference mode, REFIN is connected to GND, thereby deactivating the on-chip buffers of REFP, COM, and REFN. With their buffers shut down, these pins become high impedance inputs and can be driven by external reference sources.

#### **Clock Input (CLK)**

The MAX1444 CLK input accepts CMOS-compatible clock signals. Since the interstage conversion of the device depends on the repeatability of the rising and falling edges of the external clock, use a clock with low jitter and fast rise and fall times (<2ns). In particular, sampling occurs on the falling edge of the clock signal, mandating this edge to provide lowest possible jitter. Any significant aperture jitter would limit the SNR performance of the ADC as follows:

 $SNR = 20\log(1 / 2\pi f_{IN} t_{AJ})$ 

where  $f_{IN}$  represents the analog input frequency, and  $t_{AJ}$  is the time of the aperture jitter.

Clock jitter is especially critical for undersampling applications. The clock input should always be considered as an analog input and routed away from any analog input or other digital signal lines.

The MAX1444 clock input operates with a voltage threshold set to V<sub>DD</sub>/2. Clock inputs with a duty cycle other than 50% must meet the specifications for high and low periods as stated in the *Electrical Characteristics*. See Figures 3a, 3b, 4a, and 4b for the relationship between spurious-free dynamic range (SFDR), signal-to-noise ratio (SNR), total harmonic distortion (THD), or signal-to-noise plus distortion (SINAD) versus clock duty cycle.

#### Output Enable (OE), Power Down (PD), and Output Data (D0–D9)

All data outputs, D0 (LSB) through D9 (MSB), are TTL/CMOS-logic compatible. There is a 5.5 clock-cycle latency between any particular sample and its valid output data. The output coding is straight offset binary (Table 1). With OE and PD (power down) high, the digital output enters a high-impedance state. If OE is held low with PD high, the outputs are latched at the last value prior to the power down.

The capacitive load on the digital outputs D0–D9 should be kept as low as possible (<15pF) to avoid large digital currents that could feed back into the analog portion of the MAX1444, thus degrading its dynamic performance. The use of buffers on the ADC's digital outputs can further isolate the digital outputs from heavy capacitive loads.

Figure 5 displays the timing relationship between output enable and data output valid as well as powerdown/wake-up and data output valid.

DIFFERENTIAL INPUT VOLTAGE*	DIFFERENTIAL INPUT	STRAIGHT OFFSET BINARY
V <sub>REF</sub> × 511/512	+Full Scale -1LSB	11 1111 1111
V <sub>REF</sub> × 510/512	+Full Scale -2LSB	11 1111 1110
V <sub>REF</sub> × 1/512	+1LSB	10 0000 0001
0	Bipolar Zero	10 0000 0000
- V <sub>REF</sub> × 1/512	-1LSB	01 1111 1111
- V <sub>REF</sub> × 511/512	Negative Full Scale + 1LSB	00 0000 0001
- V <sub>REF</sub> × 512/512	Negative Full Scale	00 0000 0000

## Table 1. MAX1444 Output Code for Differential Inputs

\*VREF = VREFP - VREFN

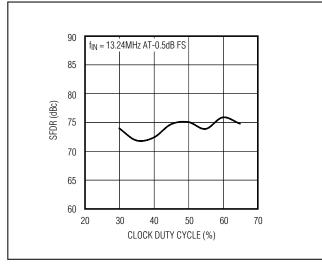


Figure 3a. Spurious-Free Dynamic Range vs. Clock Duty Cycle (Differential Input)

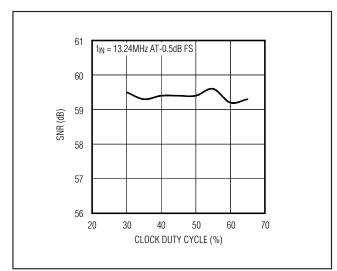
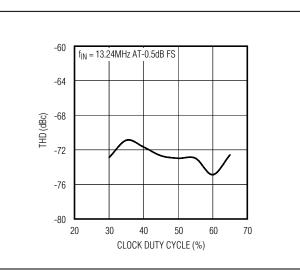
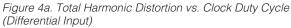


Figure 3b. Signal-to-Noise Ratio vs. Clock Duty Cycle (Differential Input)





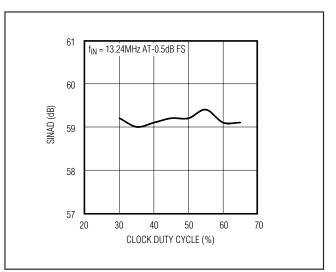


Figure 4b. Signal-to-Noise Plus Distortion vs. Clock Duty Cycle (Differential Input)

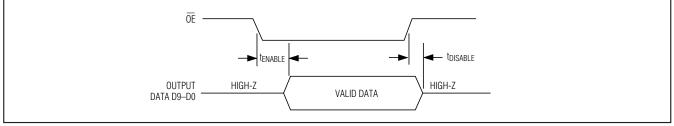


Figure 5. Output Enable Timing

## **System Timing Requirements**

Figure 6 shows the relationship between the clock input, analog input, and data output. The MAX1444 samples at the falling edge of the input clock. Output data is valid on the rising edge of the input clock. The output data has an internal latency of 5.5 clock cycles. Figure 5 shows the relationship between the input clock parameters and the valid output data.

## **Applications Information**

Figure 7 shows a typical application circuit containing a single-ended to differential converter. The internal reference provides a V<sub>DD</sub>/2 output voltage for level shifting purposes. The input is buffered and then split to a voltage follower and inverter. A lowpass filter follows the op amps to suppress some of the wideband noise associated with high-speed op amps. The user may select the RISO and CIN values to optimize the filter performance to suit a particular application. For the application in Figure 7, an RISO of  $50\Omega$  is placed before the capacitive load to prevent ringing and oscillation. The 22pF CIN capacitor acts as a small bypassing capacitor.

## **Using Transformer Coupling**

An RF transformer (Figure 8) provides an excellent solution for converting a single-ended source signal to a fully differential signal, required by the MAX1444 for optimum performance. Connecting the transformer's center tap to COM provides a  $V_{DD}/2$  DC level shift to the input. Although a 1:1 transformer is shown, a step-up transformer may be selected to reduce the drive requirements. A reduced signal swing from the input driver, such as an op amp, may also improve the overall distortion.

In general, the MAX1444 provides better SFDR and THD with fully differential input signals than singleended drive, especially for very high input frequencies. In differential input mode, even-order harmonics are lower since both inputs (IN+, IN-) are balanced, and each of the inputs only requires half the signal swing compared to single-ended mode.

## Single-Ended AC-Coupled Input Signal

Figure 9 shows an AC-coupled, single-ended application. The MAX4108 op amp provides high speed, high bandwidth, low noise, and low distortion to maintain the integrity of the input signal.

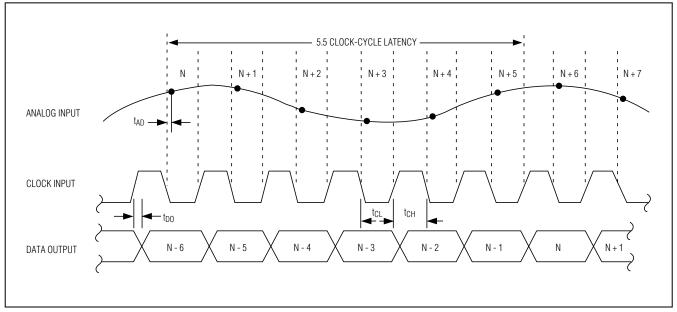


Figure 6. System and Output Timing Diagram

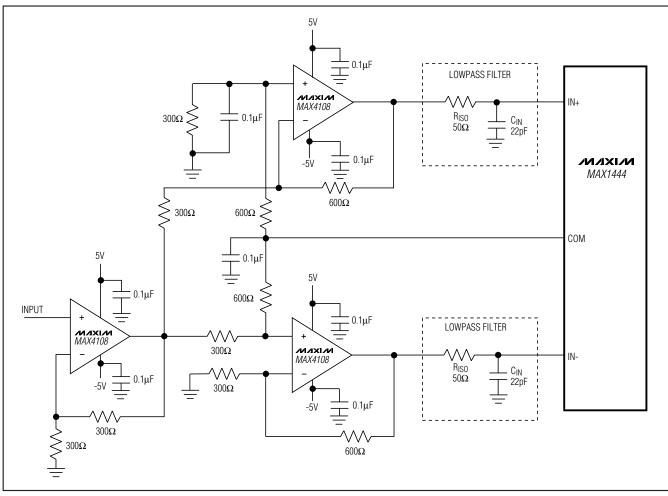


Figure 7. Typical Application Circuit for Single-Ended to Differential Conversion

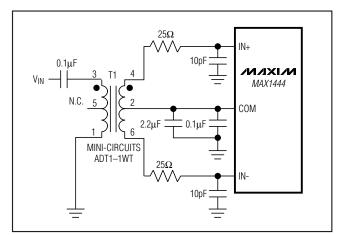


Figure 8. Using a Transformer for AC Coupling

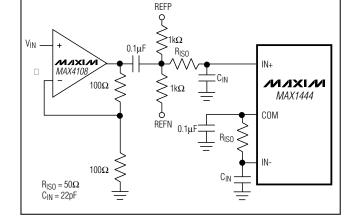


Figure 9. Single-Ended AC-Coupled Input





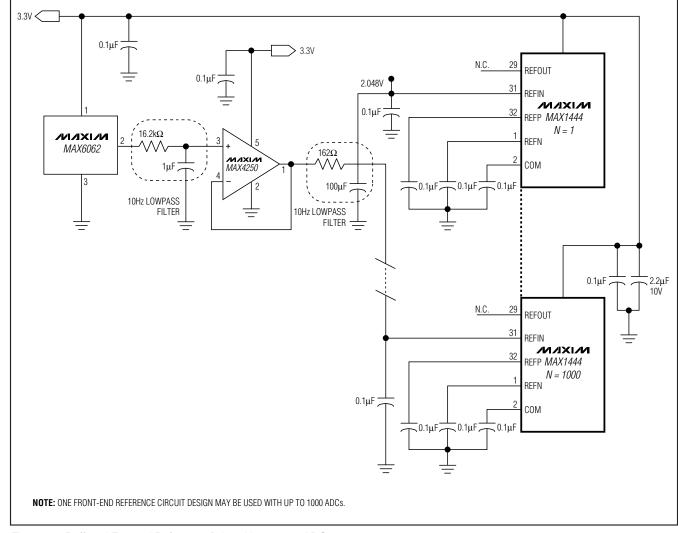


Figure 10. Buffered External Reference Drives Up to 1000 ADCs

#### Buffered External Reference Drives Multiple ADCs

Multiple-converter systems based on the MAX1195 are well suited for use with a common reference voltage. The REFIN pin of those converters can be connected directly to an external reference source. A precision bandgap reference like the MAX6062 generates an external DC level of 2.048V (Figure 10), and exhibits a noise voltage density of 150nV/ $\sqrt{\text{Hz}}$ . Its output passes through a one-pole lowpass filter (with 10Hz cutoff fre-

quency) to the MAX4250, which buffers the reference before its output is applied to a second 10Hz lowpass filter. The MAX4250 provides a low offset voltage (for high gain accuracy) and a low noise level. The passive 10Hz filter following the buffer attenuates noise produced in the voltage reference and buffer stages. This filtered noise density, which decreases for higher frequencies, meets the noise levels specified for precision ADC operation.

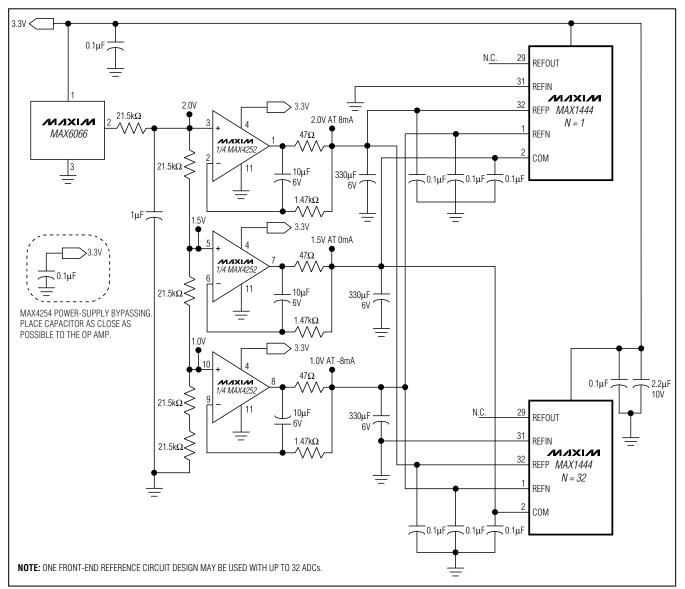


Figure 11. Unbuffered External Reference Drives Up to 32 ADCs

#### Unbuffered External Reference Drives Multiple ADCs

Connecting each REFIN to analog ground disables the internal reference of each device, allowing the internal reference ladders to be driven directly by a set of external reference sources. Followed by a 10Hz lowpass filter and precision voltage-divider (Figure 11), the MAX6066 generates a DC level of 2.500V. The buffered outputs of this divider are set to 2.0V, 1.5V, and 1.0V, with an accuracy that depends on the tolerance of the

divider resistors. The three voltages are buffered by the MAX4252, which provides low noise and low DC offset. The individual voltage followers are connected to 10Hz lowpass filters, which filter both the reference voltage and amplifier noise to a level of 3nV/ $\sqrt{Hz}$ . The 2.0V and 1.0V reference voltages set the differential full-scale range of the associated ADCs at 2VP-P. The 2.0V and 1.0V buffers drive the ADC's internal ladder resistances between them. Note that the common power supply for all active components removes any concern regarding



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power-supply sequencing when powering up or down. With the outputs of the MAX4252 matching better than 0.1%, the buffers and subsequent lowpass filters can be replicated to support as many as 32 ADCs. For applications that require more than 32 matched ADCs, a voltage reference and divider string common to all converters is highly recommended.

## Grounding, Bypassing, \_\_\_\_and Board Layout

The MAX1444 requires high-speed board layout design techniques. Locate all bypass capacitors as close to the device as possible, preferably on the same side as the ADC, using surface-mount devices for minimum inductance. Bypass V<sub>DD</sub>, REFP, REFN, and COM with two parallel 0.1 $\mu$ F ceramic capacitors and a 2.2 $\mu$ F bipolar capacitor to GND. Follow the same rules to bypass the digital supply (OV<sub>DD</sub>) to OGND. Multilayer boards with separated ground and power planes produce the highest level of signal integrity. Consider using a split ground plane arranged to match the physical location of the analog ground (GND) and the digital output driver ground (OGND) on the ADC's package.

The two ground planes should be joined at a single point so that the noisy digital ground currents do not interfere with the analog ground plane. The ideal location of this connection can be determined experimentally at a point along the gap between the two ground planes that produces optimum results. Make this connection with a low-value, surface-mount resistor (1 $\Omega$  to 5 $\Omega$ ), a ferrite bead, or a direct short. Alternatively, all ground plane is sufficiently isolated from any noisy, digital systems ground plane). Route high-speed digital signal traces away from sensitive analog traces. Keep all signal lines short and free of 90° turns.

#### **Static Parameter Definitions**

#### Integral Nonlinearity

Integral nonlinearity (INL) is the deviation of the values on an actual transfer function from a straight line. This straight line can be either a best straight-line fit or a line drawn between the endpoints of the transfer function once offset and gain errors have been nullified. The MAX1444's static linearity parameters are measured using the best straight-line fit method.

#### Differential Nonlinearity

Differential nonlinearity (DNL) is the difference between an actual step width and the ideal value of 1LSB. A DNL error specification of less than 1LSB guarantees no missing codes and a monotonic transfer function.

#### **Dynamic Parameter Definitions**

#### Aperture Jitter

Figure 12 depicts the aperture jitter  $(t_{AJ})$ , which is the sample-to-sample variation in the aperture delay.

#### Aperture Delay

Aperture delay (t<sub>AD</sub>) is the time defined between the falling edge of the sampling clock and the instant when an actual sample is taken (Figure 12).

#### Signal-to-Noise Ratio (SNR)

For a waveform perfectly reconstructed from digital samples, the theoretical maximum SNR is the ratio of the full-scale analog input (RMS value) to the RMS quantization error (residual error). The ideal, theoretical minimum A/D noise is caused by quantization error only and results directly from the ADC's resolution (N bits):

#### $SNR(MAX) = (6.02 \times N + 1.76) dB$

In reality, there are other noise sources besides quantization noise: thermal noise, reference noise, clock jitter, etc. SNR is computed by taking the ratio of the RMS signal to the RMS noise, which includes all spectral components minus the fundamental, the first five harmonics, and the DC offset.

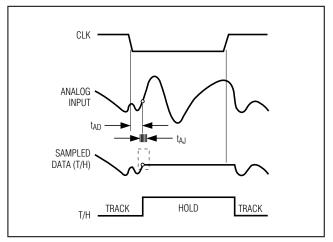


Figure 12. T/H Aperture Timing



#### Signal-to-Noise Plus Distortion (SINAD)

SINAD is computed by taking the ratio of the RMS signal to all spectral components minus the fundamental and the DC offset.

#### Effective Number of Bits (ENOB)

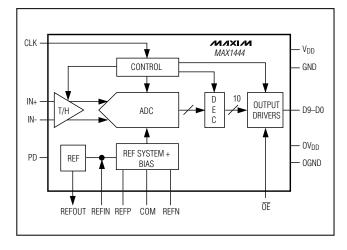
ENOB specifies the dynamic performance of an ADC at a specific input frequency and sampling rate. An ideal ADC's error consists of quantization noise only. ENOB is computed from:

$$\mathsf{ENOB} = \frac{(\mathsf{SINAD} - 1.76)}{6.02}$$

#### Total Harmonic Distortion (THD)

THD is typically the ratio of the RMS sum of the input signal's first four harmonics to the fundamental itself. This is expressed as:

THD = 20 × log 
$$\left(\frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + V_5^2}}{V_1}\right)$$



#### **Functional Diagram**

where  $V_1$  is the fundamental amplitude, and  $V_2$  through  $V_5$  are the amplitudes of the 2nd- through 5th-order harmonics.

#### Spurious-Free Dynamic Range (SFDR)

SFDR is the ratio expressed in decibels of the RMS amplitude of the fundamental (maximum signal component) to the RMS value of the next largest spurious component, excluding DC offset.

#### Intermodulation Distortion (IMD)

The two-tone IMD is the ratio expressed in decibels of either input tone to the worst 3rd-order (or higher) intermodulation products. The individual input tone levels are at -6.5dB full scale.

## Chip Information

PROCESS: CMOS

#### **Package Information**

For the latest package outline information and land patterns, go to **www.maxim-ic.com/packages**. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

PACKAGE	PACKAGE	OUTLINE	LAND
TYPE	CODE	NO.	PATTERN NO.
32 TQFP	H32+2F	<u>21-0110</u>	<u>90-0149</u>

**Revision History** 

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
3	8/10	Added MAX1444EHJ/V+ to Ordering Information	1

Maxim cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim product. No circuit patent licenses are implied. Maxim reserves the right to change the circuitry and specifications without notice at any time.

**MAX1444** 

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